

<b>Notice of References Cited</b>	Application/Control No. 10/604,058		Applicant(s)/Patent Under Reexamination CHEN ET AL.	
	Examiner James Ng		Art Unit 1763	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-3,617,536 A	11-1971	Saylor et al.	208/352
*	B	US-5,718,807 A	02-1998	Miller et al.	203/50
*	C	US-5,779,863 A	07-1998	Ha et al.	203/74
*	D	US-6,214,089 B1	04-2001	Li et al.	95/45
*	E	US-2001/0015133 A1	08-2001	Sakai et al.	95/273
*	F	US-6,436,353 B1	08-2002	Ohmi et al.	422/171
*	G	US-2003/0036272 A1	02-2003	Shamouilian et al.	438/691
*	H	US-6,605,134 B2	08-2003	Ishihara et al.	95/45
*	I	US-2004/0187683 A1	09-2004	Wang et al.	095/114
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.